

<b>Notice of References Cited</b>		Application/Control No. 10/698,976	Applicant(s)/Patent Under Reexamination MAULIK ET AL.	
		Examiner Siu M. Lee	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,741,195 b1	05-2004	Cho, Kwang-Bo	341/136
*	B	US-5,493,205	02-1996	Gorecki, James L.	323/315
*	C	US-6,720,798 b2	04-2004	Mulder et al.	327/65
*	D	US-4,943,784	07-1990	Rybicki, Mathew A.	330/264
*	E	US-2004/0096005 a1	05-2004	Zabroda, Oleksiy	375/257
*	F	US-2002/0048109 a1	04-2002	Chaiken et al.	360/67
*	G	US-6,665,347 b2	12-2003	van Bavel et al.	375/257
*	H	US-2004/0005015 a1	01-2004	Chan, Kevin T.	375/295
*	I	US-6,646,580 b2	11-2003	Clara et al.	341/136
*	J	US-6,608,860 b1	08-2003	Naviasky et al.	375/216
*	K	US-5,608,348	03-1997	Kearney et al.	327/538
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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